



COMPLEMENTARY PAIR ENHANCEMENT MODE FIELD EFFECT TRANSISTOR

Features

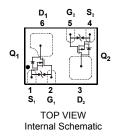
- Low On-Resistance
- Low Gate Threshold Voltage V_{GS(th)} < 1V
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Ultra-Small Surface Mount Package
- ESD Protected Gate
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: X1-DFN1612-6
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020C
- Terminal Connections: See Diagram
- Terminals: Finish NiPdAu over Copper leadframe.
 Solderable per MIL-STD-202, Method 208 @4)
- Marking Information: See Page 6
- Ordering Information: See Page 6
- Weight: 0.003 grams (approximate)

X1-DFN1612-6





Ordering Information (Note 4)

P	Part Number	Case	Packaging
DN	/IC2004LPK-7	X1-DFN1612-6	3000/Tape & Reel

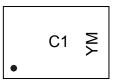
Notes: 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.

2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

Marking Information



C1 = Marking Code YM = Date Code Marking Y = Year (ex: Z = 2012) M = Month (ex: 9 = September)

Date Code Key

Year	201	2	2013		2014	20	15	2016		2017	2	2018
Code	Z		А		В	(0	D		Е		F
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings N-CHANNEL – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain Source Voltage	V _{DSS}	20	V
Gate-Source Voltage	V _{GSS}	±8	V
Drain Current (Note 5) $T_A = +25^{\circ}C$ $T_A = +85^{\circ}C$		750 540	mA

Maximum Ratings P-CHANNEL – Q_2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain Source Voltage	V _{DSS}	-20	V
Gate-Source Voltage	V _{GSS}	±8	V
Drain Current (Note 5) $T_A = +2 \\ T_A = +8$		-600 -430	mA

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 5)	PD	500	mW
Thermal Resistance, Junction to Ambient	R _{0JA}	250	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-65 to +150	°C

Electrical Characteristics N-CHANNEL – Q₁ (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	BV _{DSS}	20		—	V	$V_{GS} = 0V, I_D = 10\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_		1	μA	V _{DS} = 16V, V _{GS} = 0V
Gate-Source Leakage	IGSS	_		± 1	μA	$V_{GS} = \pm 4.5 V, V_{DS} = 0 V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	0.5	_	1.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
		_	0.4	0.55		V _{GS} = 4.5V, I _D = 540mA
Static Drain-Source On-Resistance	R _{DS (ON)}	—	0.5	0.70	Ω	V_{GS} = 2.5V, I_{D} = 500mA
	. ,	—	0.7	0.90		V _{GS} = 1.8V, I _D = 350mA
Forward Transfer Admittance	Y _{fs}	200	_	_	mS	V _{DS} =10V, I _D = 0.2A
Diode Forward Voltage (Note 6)	V _{SD}	0.5		1.2	V	V _{GS} = 0V, I _S = 115mA
DYNAMIC CHARACTERISTICS				_		
Input Capacitance	Ciss	_	_	150	pF	
Output Capacitance	Coss	_	_	25	pF	V _{DS} = 16V, V _{GS} = 0V f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}			20	pF	

Electrical Characteristics P-CHANNEL – Q₂ (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV _{DSS}	-20		_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	—	-1.0	μA	V_{DS} = -20V, V_{GS} = 0V	
Gate-Source Leakage	I _{GSS}	_	_	± 1.0	μA	$V_{GS} = \pm 4.5 V, V_{DS} = 0 V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(th)}	-0.5		-1.0	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$	
			0.7	0.9		V _{GS} = -4.5V, I _D = -430mA	
Static Drain-Source On-Resistance	R _{DS (ON)}	—	1.1	1.4	Ω	V_{GS} = -2.5V, I_{D} = -300mA	
			1.7	2.0		V_{GS} = -1.8V, I_{D} = -150mA	
Forward Transfer Admittance	Y _{fs}	200		_	mS	V _{DS} =10V, I _D = 0.2A	
Diode Forward Voltage (Note 5)	V _{SD}	-0.5	_	-1.2	V	V _{GS} = 0V, I _S = -115mA	
DYNAMIC CHARACTERISTICS							
Input Capacitance	Ciss	—	-	175	pF		
Output Capacitance	Coss	_	_	30	pF	V _{DS} = -16V, V _{GS} = 0V f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	_	20	pF		

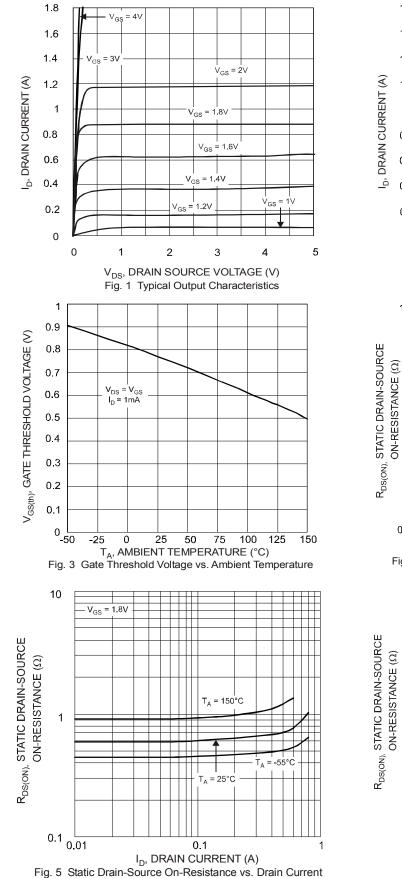
Notes: 5. Device mounted on FR-4 PCB.

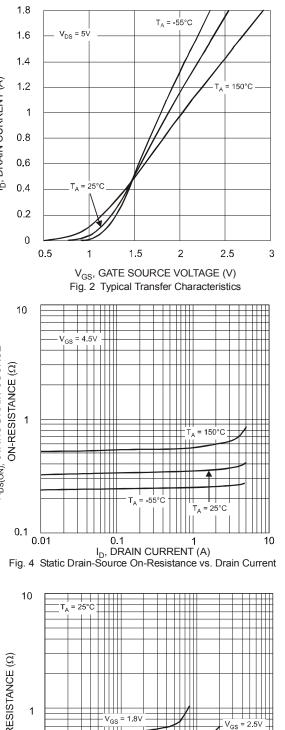
6. Short duration pulse test used to minimize self-heating effect.

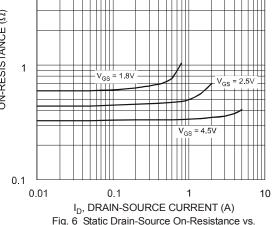


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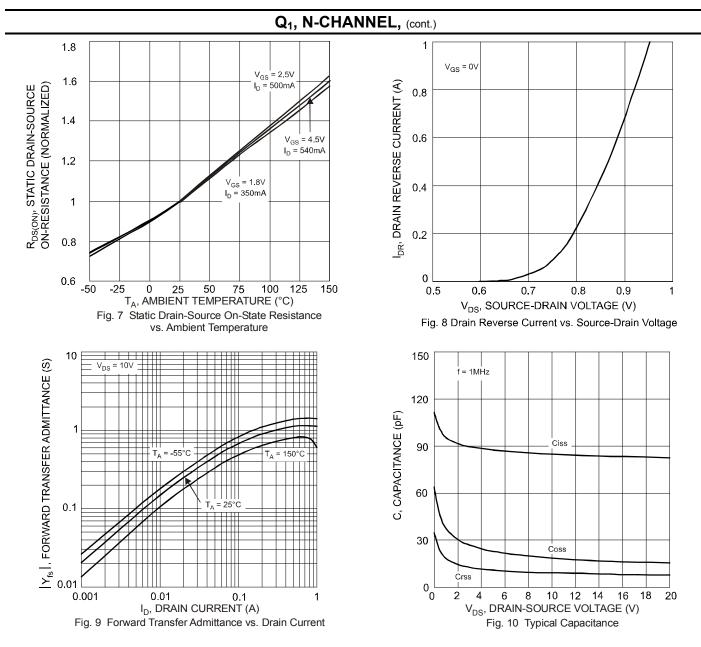




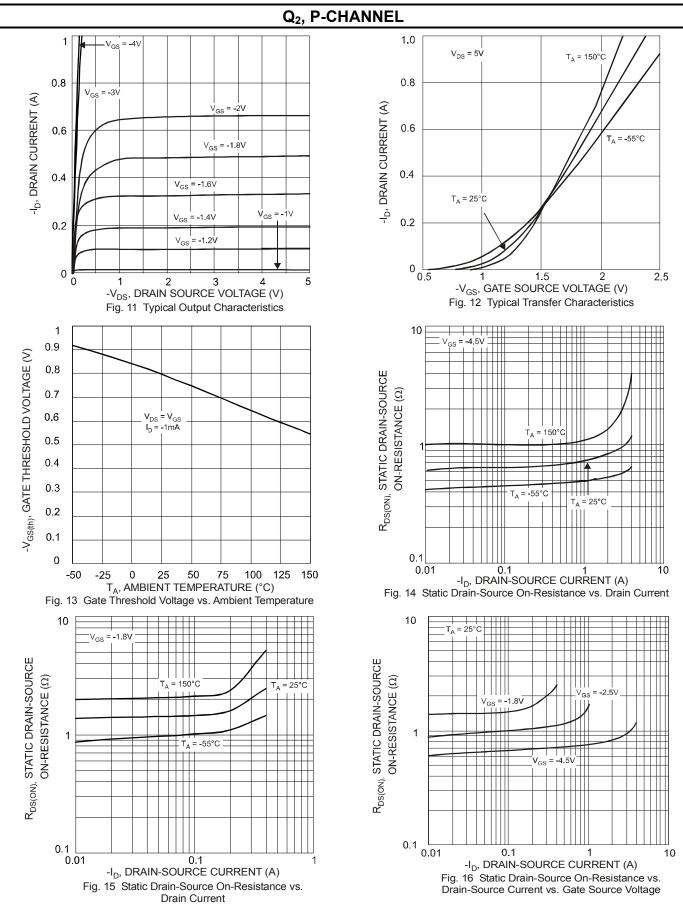
Drain-Source Current vs. Gate Source Voltage

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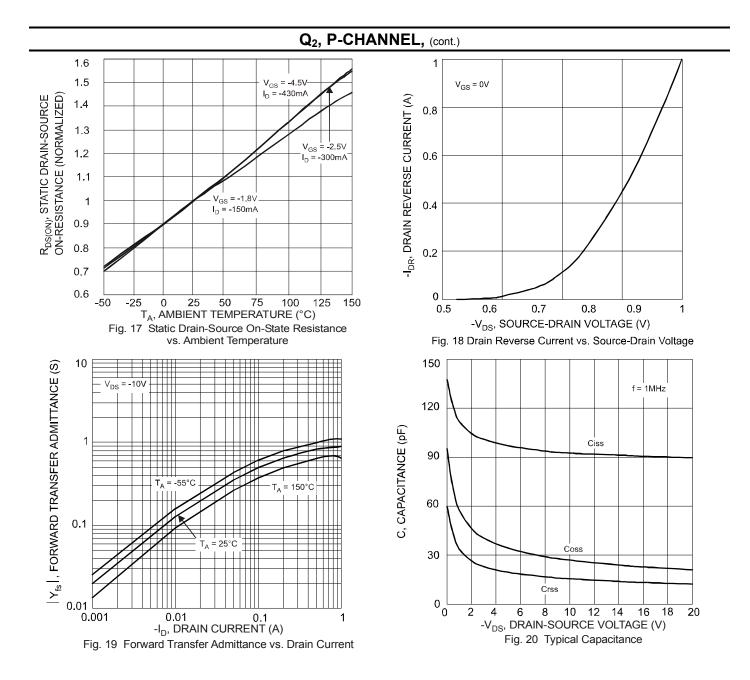






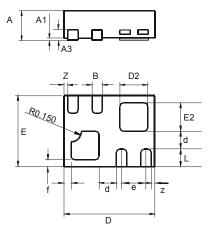






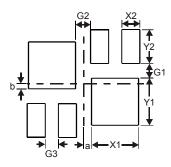


Package Outline Dimensions



X1-DFN1612-6						
Dim	Min	Max	Тур			
Α	0.47	0.53	0.50			
A1	0	0.05	0.02			
A3			0.13			
b	0.15	0.25	0.20			
D	1.55	1.675	1.60			
d	_		0.25			
D2	0.40	0.60	0.50			
Е	1.15	1.28	1.20			
е	_		0.40			
E2	0.45	0.65	0.55			
f	_	_	0.15			
L	0.20	0.30	0.25			
Ζ	_	_	0.10			
All D)imens	sions i	n mm			

Suggested Pad Layout



Dimensions	Value (in mm)
G1	0.15
G2	0.175
G3	0.15
X1	0.60
X2	0.25
Y1	0.65
Y2	0.45
а	0.10
b	0.15



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